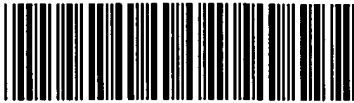


Search Notes

Application/Control No.

10/662,164

Examiner

Maikhanh Nguyen

Applicant(s)/Patent under
Reexamination

CHENG ET AL.

Art Unit

2176

SEARCHED

Class	Subclass	Date	Examiner
715	530	5/1/2006	MK
713	161,165	5/1/2006	MK
713	166,170	5/1/2006	MK
713	176	5/1/2006	MK
707	10	5/1/2006	MK
Updated	above	2/16/2007	MK
Updated	above	7/28/2007	MK
Updated	above	1/7/2008	MK
726	26	1/7/2008	MK

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
715	501.1	1/7/2008	MK
713	176 182	1/7/2008	MK
726	26	1/7/2008	MK
USPAT - USPGPub		1/7/2008	MK

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor Name Search	5/1/2006	MK
West Search (USPAT, US-PGPUB, EPO, JPO, DERWENT) See Search History Printout	5/1/2006	MK
West Updated (USPAT, US-PGPUB, EPO, JPO, DERWENT) See Search History Printout	2/16/2007	MK
West Updated (USPAT, US-PGPUB, EPO, JPO, DERWENT) See Search History Printout	7/28/2007	MK
Consulted with Primary Examiner Bashore	12/10/2007	MK
West Updated (USPAT, US-PGPUB, EPO, JPO, DERWENT) See Search History Printout	1/7/2008	MK